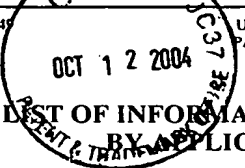


JFW

FORM PTO-1449 <div style="text-align: center;">  </div> <div style="text-align: center;"> LIST OF INFORMATION CITED BY APPLICANT <i>(Use several sheets if necessary)</i> </div>	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	FILE <div style="font-size: 1.2em;">920476-95571</div>	SERIAL NO. <div style="font-size: 1.2em;">10/780,430</div>
		APPLICANT <div style="text-align: center; font-weight: bold;">Ricardo Feced</div>	
		FILING DATE <div style="font-size: 1.2em;">2/17/2004</div>	ART UNIT <div style="font-size: 1.2em;">2633</div>

U.S. PATENT DOCUMENTS

* EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS AND SUBCLASS	FILING DATE IF APPROPRIATE
	AA	10/626,384	07/23/2003	Epworth		
	AB	10/679,824	10/06/2003	Rickard		
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS AND SUBCLASS	TRANSLATION PROVIDED
	AL					
	AM					
	AN					
	AO					
	AP					

OTHER INFORMATION

	AR	J Stott, "The Effects of Phase Noise in COFDM", EBU Technical Review - Summer 1998
	AS	
	AT	
	AU	

EXAMINER	DATE CONSIDERED
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.